## Search Notes



Application/Control No.
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10575425

Applicant(s)/Patent Under Reexamination

PROUET ET AL.

Examiner JOHN W POOS Art Unit

2816

## SEARCHED

Class	Subclass	Date	Examiner			
327	103	11/29/2007	JP			
323	315	12/3/2007	JP			

## SEARCH NOTES

Search Notes	Date	Examiner
terms used to constrain subclasses above: chip, different sized transistors,	11/29/2007	JP
transconductance, differential input voltage		
Inventor search in EAST and eDAN	12/3/2007	JP
Update Search see attached Search History	4/25/2008	JP
Update Search: see attached EAST search history	10/10/2008	JP

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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